

**Search Notes**

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Examiner

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Applicant(s)/Patent under  
Reexamination

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Art Unit

2831

**SEARCHED**

Class	Subclass	Date	Examiner
174	110R	12/20/2007	CN
	113R		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR